

Search Notes**Application/Control No.**

10/758,192

Examiner

YALKEW FANTU

**Applicant(s)/Patent under
Reexamination**

HORIGOME, HIDEO

Art Unit

2838

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
((charg\$3)unit or apparatus or device or equipment))(second		8/28/2008	YF

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
search updated	8/28/2008	YF
interference searched	8/28/2008	YF